

<b>Notice of References Cited</b>	Application/Control No. 10/597,200	Applicant(s)/Patent Under Reexamination LEE, JONG-LAM	
	Examiner THINH T. NGUYEN	Art Unit 2818	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0001170	01-2003	Shibata et al.	257/189
*	B	US-6,326,294	12-2001	Jang et al.	438/604
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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